

In re the Application of: MARUYAMA, Shigeyuki et al. Attention: Applications Division

Serial Number: 10/685,542 Group Art Unit: 2858

Filed: October 16, 2003 P.T.O. Confirmation No.: 6009

For: SEMICONDUCTOR TESTING DEVICE

REQUEST FOR CORRECTED FILING RECEIPT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Date: April 9, 2004

Sir:

Please supply the undersigned attorney with a corrected filing receipt for the above-identified application. The undersigned also respectfully requests that the Patent and Trademark Office records be amended to reflect the correction.

In reviewing the official Filing Receipt, we noted an error in that the fourth assignee's name should be omitted. A copy of the Request for Deletion of Inventor named in Present Application filed on April 8, 2004 is enclosed which indicates the correct information. We are enclosing a copy of the filing receipt with the corrections highlighted.

In the event that any fees are required in connection with this paper, please charge our Deposit Account No. 01-2340.

Respectfully submitted,

ARMSTRONG, KRATZ, QUINTOS, HANSON & BROOKS, LLP

> George N. Stevens Attorney for Applicants Reg. No. 36,938

GNS/bjb Atty. Docket No. 990250B Suite 1000 1725 K Street, N.W. Washington, D.C. 20006

(202) 659-2930

23850

PATENT TRADEMARK OFFICE

Enclosures: Official Filing Receipt

Request for Deletion of Inventor Named in Present Application filed on

April 8, 2004

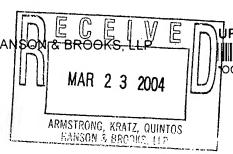




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	APPL NO.	FILING OR 371 (c) DATE	ART UNIT	FIL FEE REC'D	ATTY.DOCKET NO	DRAWINGS	TOT CLMS	IND CLMS
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23850 ARMSTRONG, KRATZ, QUINTOS, HANSONIA BROO 1725 K STREET, NW **SUITE 1000** WASHINGTON, DC 20006



CONFIRMATION NO. 6009 PDATED FILING RECEIPT OC000000012154801*

Date Mailed: 03/22/2004

Receipt is acknowledged of this regular Patent Application. It will be considered in its order and you will be notified as to the results of the examination. Be sure to provide the U.S. APPLICATION NUMBER, FILING DATE, NAME OF APPLICANT, and TITLE OF INVENTION when inquiring about this application. Fees transmitted by check or draft are subject to collection. Please verify the accuracy of the data presented on this receipt. If an error is noted on this Filing Receipt, please write to the Office of Initial Patent Examination's Filing Receipt Corrections, facsimile number 703-746-9195. Please provide a copy of this Filing Receipt with the changes noted thereon. If you received a "Notice to File Missing Parts" for this application, please submit any corrections to this Filing Receipt with your reply to the Notice. When the USPTO processes the reply to the Notice, the USPTO will generate another Filing Receipt incorporating the requested corrections (if appropriate).

Applicant(s)

Shigeyuki Maruyama, Kawasaki-shi, JAPAN: Kazuhiro Tashiro, Kawasaki-shi, JAPAN; Makoto Haseyama, Kawasaki-shi, JAPAN; Futoshi Fukaya, Kawasaki-shi, JAPAN, Delete

Assignment For Published Patent Application

FUJITSU LIMITED, Kawasaki, JAPAN;

Domestic Priority data as claimed by applicant

This application is a DIV of 09/828,221 04/09/2001 PAT 6,661,247 which is a DIV of 09/268,338 03/16/1999 PAT 6.249.135 which is a CIP of 09/009,261 01/20/1998 ABN

Foreign Applications

JAPAN 9-255786 09/19/1997 · JAPAN 10-263579 09/17/1998 -

If Required, Foreign Filing License Granted: 01/20/2004

Projected Publication Date: 07/01/2004

Non-Publication Request: No

Early Publication Request: No



Title

Semiconductor testing device

Preliminary Class

324

LICENSE FOR FOREIGN FILING UNDER Title 35, United States Code, Section 184 Title 37, Code of Federal Regulations, 5.11 & 5.15

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In re the Application of: MARUYAMA, Shigeyuki et al.

Group Art Unit: 2829

Serial No.: 10/685,542

Examiner: Russell M. Kobert

Filed: October 16, 2003

For:

SEMICONDUCTOR TESTING DEVICE

REQUEST FOR DELETION OF INVENTOR NAMED IN PRESENT APPLICATION

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

April 8, 2004

Sir:

It is respectfully requested that the following inventor who was named in prior application Serial No. 09/828,221, be deleted from the above-identified patent application which claims priority under 35 USC §120 based on said prior application:

Futoshi Fukaya

The deletion of the above-mentioned inventor is due to the fact that he does not contribute to the claims recited in this application.

In the event any fees are due in connection with this request, please charge such fees to our Deposit Account No. 01-2340.

> Respectfully submitted, ARMSTRONG, KRATZ, QUINTOS, HANSON & BROOKS, LLP

> > George N. Stevens Attorney for Applicant Reg. No. 36,938

GNS/alw Atty. Docket No. 990250B Suite 1000 1725 K Street, N.W. Washington, D.C. 20006 (202) 659-2930

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